

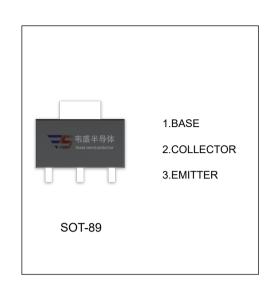
2SD1664 TRANSISTOR (NPN)

FEATURES

- Low $V_{CE(sat)}$, $V_{CE(sat)}$ =0.15V(typical).(I_C/I_B =500mA/50mA)
- Complements to 2SB1132

MAXIMUM RATINGS (Ta=25°C unless otherwise noted)

Symbol	Parameter	Value	Unit			
V _{CBO}	Collector-Base Voltage	40	V			
V _{CEO}	Collector-Emitter Voltage	32	V			
V _{EBO}	Emitter-Base Voltage	5	V			
Ic	Collector Current -Continuous	1	Α			
Pc	Collector power dissipation	500	mW			
T _J ,T _{stg}	Operation Junction and Storage Temperature Range	-55~150	℃			



ELECTRICAL CHARACTERISTICS (Ta=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-base breakdown voltage	V _{(BR)CBO}	I _C =50μA, I _E =0	40			V
Collector-emitter breakdown voltage	V _{(BR)CEO}	I _C =1mA, I _B =0	32			V
Emitter-base breakdown voltage	V _{(BR)EBO}	I _E =50μA, I _C =0	5			V
Collector cut-off current	I _{CBO}	V _{CB} =20V, I _E =0			0.5	μΑ
Emitter cut-off current	I _{EBO}	V _{EB} =4V, I _C =0			0.5	μΑ
DC current gain	h _{FE}	V _{CE} =3V, I _C =100mA	82		390	
Collector-emitter saturation voltage	V _{CE(sat)}	I _C =0.5A, I _B =50mA			0.4	V
Transition frequency	f _T	V _{CE} =5V, I _C =50mA, f=100MHz		150		MHz
Collector output capacitance	C _{ob}	V _{CB} =10V, I _E =0, f=1MHz		15		pF

CLASSIFICATION OF hFE

Rank	Р	Q	R
Range	82-180	120-270	180-390
Marking	DAP	DAQ	DAR



